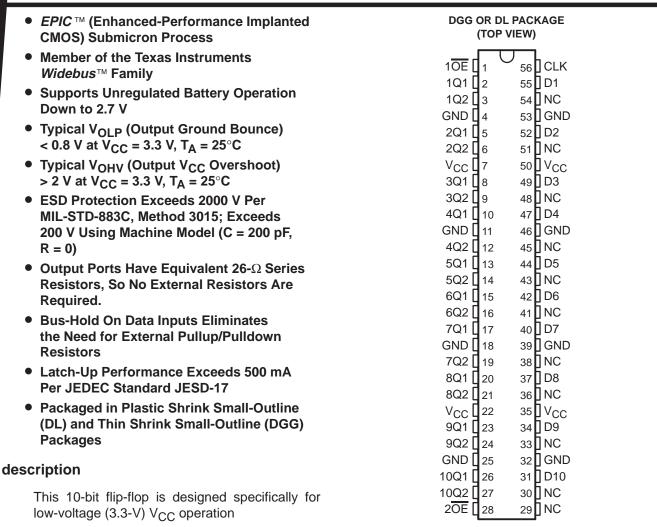
SN74ALVC162820 3.3-V 10-BIT FLIP-FLOP WITH DUAL OUTPUTS AND SERIES-DAMPING RESISTORS AND 3-STATE OUTPUTS

SCAS278 - OCTOBER 1993 - REVISED MARCH 1994



The flip-flops of the SN74ALVC162820 are edge-triggered D-type flip-flops. On the positive transition of the clock (CLK) input, the device provides true data at the Q outputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components.

The output-enable (\overline{OE}) input does not affect the internal operations of the flip-flops. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

The outputs, which are designed to sink up to 12 mA, include 26- Ω resistors to reduce overshoot and undershoot.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN74ALVC162820 is available in TI's shrink small-outline (DL) and thin shrink small-outline (DGG) packages, which provide twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

The SN74ALVC162820 is characterized for operation from -40°C to 85°C.

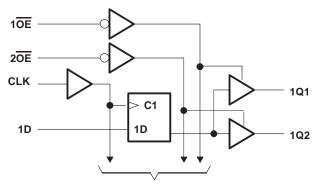
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FUNCTION TABLE (each flip-flop)

INPUTS		OUTPUT		
OE	CLK	D	Q	
L	1	Н	Н	
L	\uparrow	L	L	
L	L	Χ	Q ₀	
Н	X	Χ	Z	

logic diagram (positive logic)



To Nine Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V _{CC}	0.5 V to 4.6 V
Input voltage range, V _I (except I/O ports) (see Note 1)	$\cdots -0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input voltage range, V _I (I/O ports) (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Output voltage range, VO (see Note 1)	$-0.5 \text{ V to V}_{CC} + 0.5 \text{ V}$
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$)	±50 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC})	±50 mA
Continuous current through V _{CC} or GND pins	±100 mA
Maximum power dissipation at $T_A = 55^{\circ}C$ (in still air): DGG particles	ckage 1 W
DL pack	age 1.4 W
Storage temperature range	65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.



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recommended operating conditions

			MIN	MAX	UNIT
VCC	V _{CC} Supply voltage		2.7	3.6	V
VIH	High-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		V
VIL	Low-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8	V
V _I Input voltage		0	VCC	V	
٧o	VO Output voltage		0	VCC	V
ЮН	High-level output current	V _{CC} = 2.7 V		-8	mA
		V _{CC} = 3 V		-12 [†]	
lOL	Low-level output current	V _{CC} = 2.7 V		8	mA
		V _{CC} = 3 V		12†	
$\Delta t/\Delta v$ Input transition rise or fall rate		0	10	ns/V	
T _A Operating free-air temperature		-40	85	°C	

[†] Current duty cycle ≤ 50%, f ≥ 1 kHz

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	v _{cc} ‡	MIN	TYP MAX	UNIT
VIK	$I_{I} = -18 \text{ mA}$	2.7 V		-1.2	V
VOH	I _{OH} = -100 μA	MIN to MAX	V _{CC} -0.2		V
	$I_{OH} = -8 \text{ mA}$	2.7 V	2		
	$I_{OH} = -12 \text{ mA}$	3 V	2		
V _{OL}	I _{OL} = 100 μA	MIN to MAX		0.2	V
	$I_{OL} = 8 \text{ mA}$	2.7 V		0.8	
	I _{OL} = 12 mA	3 V		0.8	
lį	$V_I = V_{CC}$ or GND	3.6 V		±5	μΑ
l(hold)	V _I = 0.8 V	3 V	75		μΑ
	V _I = 2 V	3 V	-75		μΑ
I _{OZ}	$V_O = V_{CC}$ or GND	3.6 V		±10	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V		40	μΑ
△ICC	$V_{CC} = 3 \text{ V to } 3.6 \text{ V},$ One input at $V_{CC} - 0.6 \text{ V},$ Other inputs at V_{CC} or GND			750	μА
C _i	$V_I = V_{CC}$ or GND	3.3 V			pF
Co	$V_O = V_{CC}$ or GND	3.3 V			pF

For conditions shown as MIN or MAX, use the appropriate values under recommended operating conditions.



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